

# Effect of variation of precursor concentration on structural, microstructural, optical and gas sensing properties of nanocrystalline TiO<sub>2</sub> thin films prepared by spray pyrolysis techniques

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**Abstract.** The objective of the present paper is to investigate the effect of variation of precursor concentration (0.01, 0.02 and 0.03 M) on the structural, microstructural, optical and gas sensing properties of TiO<sub>2</sub> thin films. Titanium dioxide (TiO<sub>2</sub>) films were prepared from aqueous solution of titanium chloride (TiCl<sub>3</sub>·6H<sub>2</sub>O, 99.9% pure, Merck made, Germany) onto the glass substrates heated at a temperature of 350 °C by the spray pyrolysis technique. Bandgap energy of the films vary from 3.28 to 3.29 eV. X-ray diffraction shows that films to be nanocrystalline with anatase phase having tetragonal crystal structure. The *d* values calculated from electron diffraction patterns (TEM) were observed to be matching with *d* values calculated from XRD. Transmission electron microscopy (TEM) revealed that grain sizes were observed to increase (10–29 nm) with an increase in the concentration of precursor solution. The gas sensing performance of the films was tested.

**Keywords.** Spray pyrolysis; nanocrystalline TiO<sub>2</sub>; electron diffraction pattern.

## 1. Introduction

Various types of sensors with different operating principles have been explored including the resistive type (Semancik and Cavicchi 1991; Michel *et al* 1998; Dresselhaus and Thomas 2001), thermoelectric (Shin *et al* 2004) and potentiometric (Maffei and Kuriakose 2004). Liquefied petroleum gas (LPG) is a highly inflammable gas. It is explosively utilized in industrial and domestic fields as fuel. It is referred to as town or cooking gas. This gas is potentially hazardous because explosion accidents might be caused, when it leaks out easily. It has been reported that, at concentration up to noticeable leakage, it is very much more than the lower explosive limit (LEL) of the gas in air. There is a great demand and emerging challenges for gas sensors to monitor LPG (Patil *et al* 2006, 2010; Sahay and Nath 2008) for the purpose of control and safe applications in domestic and industrial fields.

Nanostructured materials of nanometer-sized (1–100 nm) particles are particularly interesting for applications in advanced materials that require high reactivity, low superplasticity and unusual electrooptical properties (Panatarani *et al* 2003). In recent years, interest on titanium dioxide have increased tremendously due to its attractive physical, chemical and optical properties (Linsebigier *et al* 1995; Bhuvanesh and Gopal 1997). Nanocrystalline titanium dioxide (TiO<sub>2</sub>) offers great attention due to its wide energy gap (3.2 eV), high-electrochemical stability, refractive index and dielectric constant (Diebold 2003; More *et al* 2007). TiO<sub>2</sub> is an impor-

tant semiconductor material, having a wide range of applications such as gas sensors (Hayakawa *et al* 2000; Devi *et al* 2002; Ruiz *et al* 2002, 2004; Zhu *et al* 2002; Chen *et al* 2004), photo-catalysis (Fujishima *et al* 2000; Linkous *et al* 2000; Yang and Davis 2000; Maldoti *et al* 2002; Anpo and Takeuchi 2003), solar cells (Bach *et al* 1998; Grätzel 2001; Adachi 2004). Several methods for the growth of TiO<sub>2</sub> thin films have been reported (Young *et al* 1987; Chaudhari *et al* 2006; Kale *et al* 2006), but they are expensive. On the other hand, chemical spray pyrolysis method is economical and porous structures with high surface area can be grown by a simple method.

Nanostructure TiO<sub>2</sub> thin films were prepared by spray pyrolysis deposition technique (SPD). Because the film formation is carried out in air by a simple apparatus in SPD, technique is one of the most attractive film preparation methods. SPD is essentially pyrosol technique, in which a source solution is sprayed on the heated substrate to be deposited as a film. In other words, when source solutions are atomized, small droplets splash and vapourize on the substrate and leave a dry precipitate in which thermal decomposition occurs (Viguie and Spitz 1975). Organometallic compounds and inorganic salts are used as source materials, which are dissolved in water, ethanol or other solvents to prepare source solutions. Because, the source materials dissolve in a solvent as an ion, oligomer, cluster or sol, depending on their chemical properties. The surface morphology of deposited films are easily controlled by choosing species of the source materials (Okuya *et al* 1999, 2002a, b).

In the present study, we have developed a spray pyrolysis technique to prepare nanocrystalline TiO<sub>2</sub> thin films.

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As prepared TiO<sub>2</sub> thin films (0.02 M) give maximum gas response to LPG and H<sub>2</sub> at operating temperatures of 350 and 250 °C, respectively. The effect of precursor concentrations on structural, microstructural, optical and gas sensing properties were studied.

## 2. Experimental

### 2.1 Experimental set up to prepare nanostructured thin films

Figure 1 shows a chemical spray pyrolysis technique for the preparation of nanocrystalline TiO<sub>2</sub> thin films. Setup consists of spraying chamber, spray gun, air compressor, temperature controller and heater. Transparent, conducting, nanocrystalline TiO<sub>2</sub> thin films were prepared from aqueous solution of TiCl<sub>3</sub>·6H<sub>2</sub>O (99.9% pure, Merck made, Germany) having different concentrations (0.01, 0.02 and 0.03 M). The spray produced by nozzle was sprayed onto the glass substrates heated at 350 °C. Various parameters such as nozzle-to-substrate distance, deposition time, flow rate of solution and deposition temperature were optimized to obtain films of good quality.

### 2.2 Preparation of nanocrystalline TiO<sub>2</sub> thin films

For the deposition of TiO<sub>2</sub> thin films by spray pyrolysis, the precursor solution was prepared by dissolving titanium chloride (TiCl<sub>3</sub>·6H<sub>2</sub>O, 99.9% pure, Merck made, Germany) in double-distilled water. The spraying solution concentrations were: 0.01, 0.02 and 0.03 M. Table 1 shows preparative

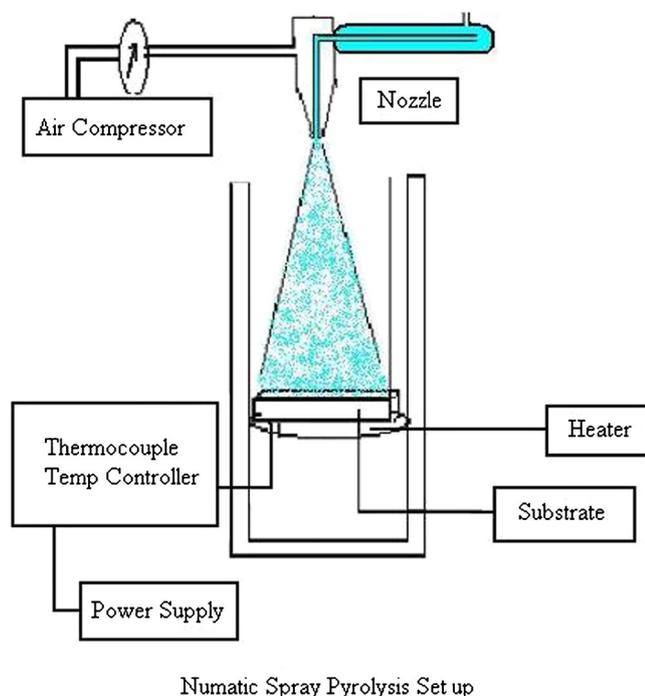


Figure 1. Spray pyrolysis system set up.

conditions of nanocrystalline TiO<sub>2</sub> thin films using spray pyrolysis.

### 2.3 Details of gas sensing system

The sensing performance of the sensors was examined using “static gas sensing system” explained elsewhere (Jain et al 2006).

## 3. Characterization of nanocrystalline TiO<sub>2</sub> thin film and results

The structural analysis of nanocrystalline TiO<sub>2</sub> thin films was carried out by XRD (Rigaku DMAX 2500) with CuKα radiation at a wavelength of 1.5418 Å. Electron diffraction patterns of nanocrystalline TiO<sub>2</sub> thin films were obtained using TEM (Philips EM 400). A UV–Visible spectrophotometer (Shimadzu 2450 UV–Vis) was used to study the optical properties of nanocrystalline TiO<sub>2</sub> thin films. The thickness and roughness of thin films were measured by using Surface Profiler [AMBIOS Tech. (USA) XP-I].

### 3.1 Thickness and roughness determination of TiO<sub>2</sub> thin films

The thickness of thin films was measured (table 2) by using Surface Profiler (AMBIOS Tech. (USA) XPI) having a vertical resolution of 1.5 Å, lateral resolution of 100 nm and lateral length of 200 nm. It is clear from table 2, that thicknesses of nanocrystalline TiO<sub>2</sub> sample are increasing with increase in precursor concentration. Roughness of sample S2 is higher than the roughness of samples S1 and S3.

### 3.2 Structural properties: X-ray diffraction studies

Figure 2 shows XRD spectra of samples S1, S2 and S3. The observed “*d*” values of TiO<sub>2</sub> confirmed that the deposited films are of TiO<sub>2</sub> anatase phase with tetragonal structure matching well with ASTM data book, card no. 21-1272. One additional minor peak along (213) is observed for thicker film (S3). In XRD pattern, (101) peak has the most distinct reflection. So, the mean crystalline size is calculated with the line broadening of (101) reflection (S1, S2 and S3) using well known Scherrer equation (1):

$$d = 0.9\lambda / \beta \cos \theta \quad (1)$$

where *d* is crystallite size,  $\beta$  the full width at half maxima in radian and  $\lambda$  is the wavelength of X-ray (1.5418 Å). The crystallite size was observed to be increasing with precursor concentration as presented in table 3.

Crystallinity of the material has direct dependence on the film thickness. Crystallinity has been observed to improve with an increase of the film thickness (Chang et al 2002). Moreover, the increase of crystallite size could be attributed to the improvement of crystallinity and an increase in the cluster formation leading to agglomeration of small crystallites. These agglomerated crystallites coalesce together

**Table 1.** Process parameters for spray deposition of TiO<sub>2</sub> thin films.

Sample	Concentration (M)	Pyrolysis temp. (°C)	Firing temp. (°C)	Compressed air (kg/cm <sup>2</sup> )	Spray rate (ml/min)
S1	0.01	350	550	2.5	4.9
S2	0.02	350	550	2.5	4.9
S3	0.02	350	550	2.5	4.9

resulting in the formation of larger crystallites with better crystallinity.

### 3.3 Microstructure and electron diffraction using TEM

Figures 3(a), (c) and (e) show transmission electron micrograph [CM 200 Philips (200 kV HT)] of powders obtained by scratching the thin film samples: S1, S2 and S3 respectively. The powder was dispersed in ethanol. TEM uses copper grid to hold the powder. The sample particles on the grid were scanned in all the zones before the picture was taken. Figure 3(a) shows that grains are spherical or ellipsoidal in nature with an average grain size of 10 nm. It is clear from figure 3(c) that large number of grains are distributed randomly having spindle shape with an average grain size of 22 nm. Figure 3(e) shows that grains distributed randomly having spindle shape with an average grain size of 29 nm. It is clear from table 4 that the grain size of samples (S1, S2 and S3) is increasing with increase in precursor concentration.

Figures 3(b) and (d) show electron diffraction patterns of S1 and S2 samples, respectively. The electron diffraction patterns show clear and continuous ring patterns revealing their polycrystalline structure. Five fringe patterns corresponding to planes: (1 0 1), (0 0 4), (2 0 0), (2 1 1) and (2 0 4) are consistent with the peaks observed in XRD patterns. XRD and TEM studies confirmed pure tetragonal structure of TiO<sub>2</sub> as evidenced from figures 2 and 3, respectively.

The distance from centre to each ring (moving from the smallest to larger ones) is measured to be 2.801, 4.211, 5.402, 6.121 and 6.970 nm, respectively for samples S1 and 2.790, 4.271, 5.462, 6.170 and 7.100 nm, respectively for sample S2. This is indicated in figures 3(b) and (d) and expressed in terms of nm<sup>-1</sup>. The reciprocal of these values give the interplanar distance *d*. Details are given in table 5.

It is clear from table 5 that *d* values calculated from electron diffraction patterns (TEM) of nanocrystalline TiO<sub>2</sub> thin films matched with *d* values calculated from XRD.

**Table 2.** Thickness and roughness of TiO<sub>2</sub> thin films for different concentrations.

Sample	Concentration (M)	Thickness (nm)	Roughness (nm)
S1	0.01	223.8	33.3
S2	0.02	534.2	82.7
S3	0.03	652.2	33.9

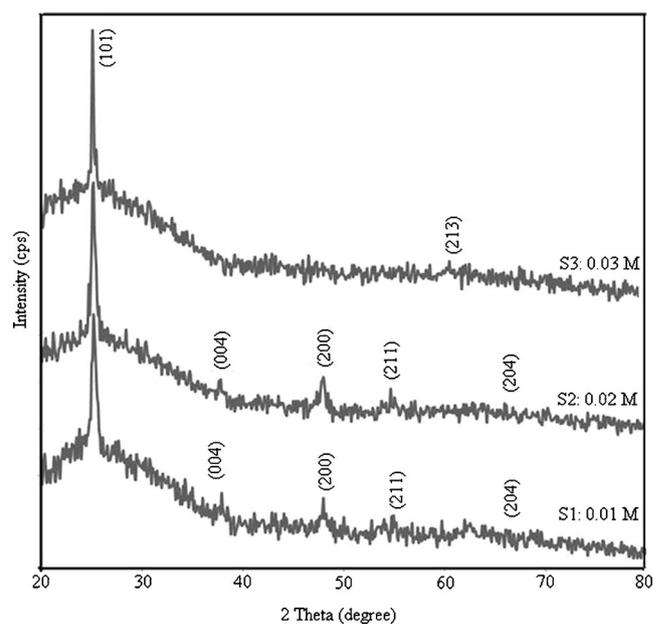
### 3.4 Optical absorption

Figure 4 shows variation of absorbance with wavelength of nanocrystalline TiO<sub>2</sub> thin films in the range of 300–600 nm. The bandgap energy of the samples was calculated from the absorption edges of the spectra (Bari *et al* 2006). The bandgap was observed to be slightly varying from 3.28 to 3.29 eV. Bandgap of S1 < S2, bandgap of S2 < bandgap of S3. These values nearly match with the reported value of TiO<sub>2</sub>, i.e. 3.2 eV (Brady 1971; Daude *et al* 1977; Tang *et al* 1994). It is clear from the absorption spectra that concentration does not affect much for the bandgap energy of nanocrystalline TiO<sub>2</sub> thin films.

## 4. Electrical properties of sensor

### 4.1 I–V characteristics

Figure 5 shows I–V characteristics of nanostructured TiO<sub>2</sub> thin films. The graphs are observed to be symmetrical in nature indicating ohmic contact.

**Figure 2.** X-ray diffraction spectra of samples: S1 (0.01 M), S2 (0.02 M) and S3 (0.03 M).

## 5. Sensing performance of the sensor

### 5.1 Gas sensing performance of thin film resistors

The thin film sensors mounted on static gas sensing system (Jain *et al* 2006; Wagh *et al* 2006; Patil *et al* 2007) were tested on exposure of ethanol, carbon dioxide, LPG, ammonia, chlorine and hydrogen. Values of current before and after

exposure of gas were measured and gas responses at various operating temperatures were determined.

### 5.2 Measurement of gas response and selectivity

Gas response ( $S$ ) is defined as the ratio of the change in conductance of the sensor on exposure to the target gas to the original conductance in air. The relation for  $S$  is given as

$$S = (G_g - G_a)/G_a, \quad (2)$$

where  $G_a$  and  $G_g$  are the conductance of sensor in air and in a target gas medium, respectively.

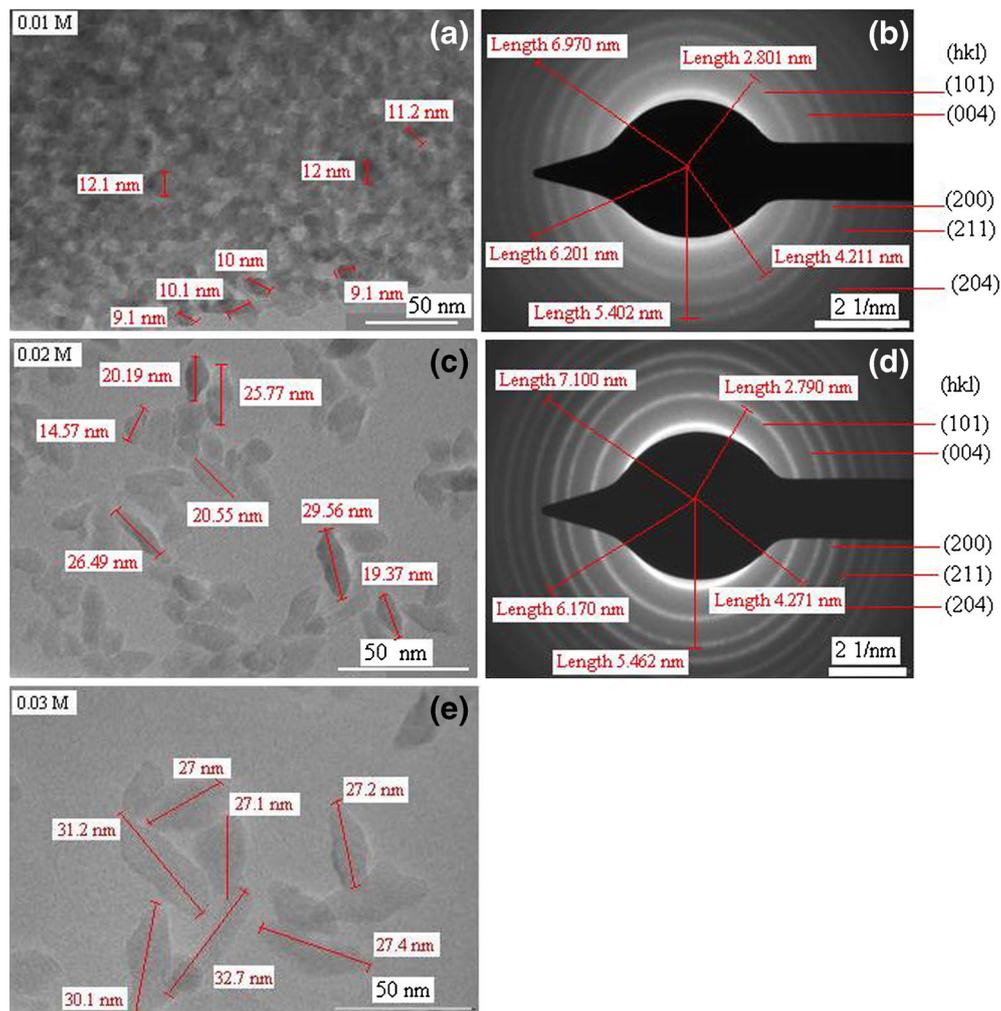
Selectivity or specificity is defined as the ability of a sensor to respond to a certain gas in the presence of other gases.

### 5.3 Variation of gas response with operating temperature for LPG and $H_2$

Figures 6(a) and (b) show variation of LPG and  $H_2$  responses with operating temperature, respectively. It is clear from

**Table 3.** Grain size calculated from XRD.

Sample	Concentration (M)	Grain size calculated from XRD (nm)
S1	0.01	9.24
S2	0.02	21.70
S3	0.03	29.50



**Figure 3.** (a) TEM image, (b) electron diffraction image of sample S1, (c) TEM image, (d) electron diffraction image of sample S2 and (e) TEM image of sample S3.

figures 6(a) and (b) that gas response of each sample increases with operating temperature, reaches to a maximum for LPG ( $S = 82$ ) at 350 °C, for H<sub>2</sub> ( $S = 54$ ) at 250 °C (sample S2) and falls with further increase in operating temperature. Sensor S2 is most sensitive to LPG at 350 °C and to H<sub>2</sub> at 250 °C as compared to sensors S1 and S3.

It is clear from table 2 that roughness of sample S2 is more as compared to samples S1 and S3. Surface roughness of films are important because it affects shift in electronic energy levels and degrades electrical characteristics (Young-Bae *et al* 2003). Porosity of thin film is related to the surface roughness. Roughness of sample S2 is higher than S1 and S3. This may be the reason that sample S2 gives the highest gas response to LPG and H<sub>2</sub> as compared to S1 and S3.

High sensitivity of S2 may be due to optimum particle size which would have created good porosity and hence, high effective surface area in the film. Higher the surface area for interaction with exposed gas, higher would be the sensitivity to the gas. Smaller particles in case of film S1 may not allow the film to be too porous. This hampers the effective area. Larger particle in case of S3 may not result into high effective surface area to interact with the gas.

#### 5.4 Selectivity of LPG and H<sub>2</sub> against various gases

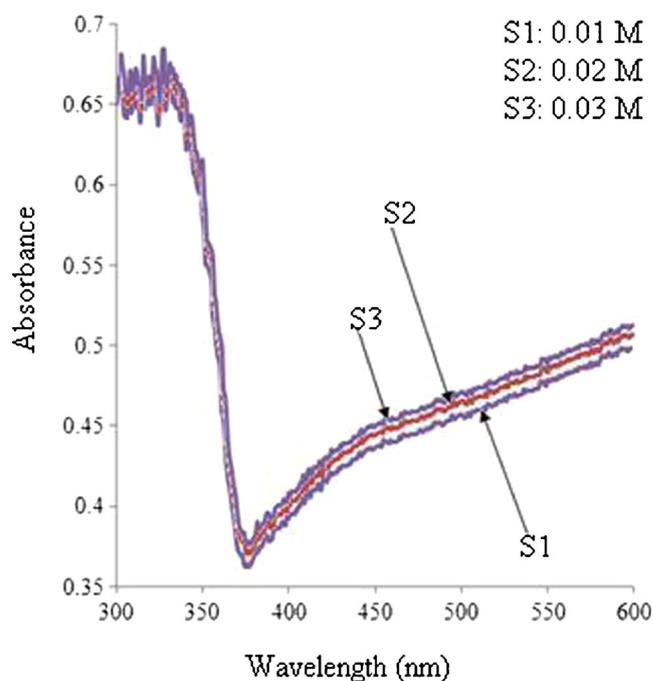
Figure 7(a) shows selectivity of S1, S2 and S3 thin films to LPG against H<sub>2</sub>, CO<sub>2</sub>, NH<sub>3</sub>·Cl<sub>2</sub> and ethanol gases at 350 °C. Figure 7(b) shows selectivity to H<sub>2</sub> against LPG, CO<sub>2</sub>, NH<sub>3</sub>·Cl<sub>2</sub> and ethanol gases at 250 °C. It is clear from the figure that nanostructured TiO<sub>2</sub> thin films S1, S2 and S3

**Table 4.** Grain size observed from TEM.

Sample	Concentration (M)	Grain size observed from TEM (nm)
S1	0.01	10
S2	0.02	22
S3	0.03	29

**Table 5.**  $d$  values obtained from XRD and TEM.

Reported $d$ values	X-ray diffraction (XRD) $d$ values		Electron diffraction (TEM) Sample S1		Electron diffraction (TEM) Sample S2		Planes ( $hkl$ )
	Sample S1	Sample S2	Reciprocal of $d$ values $\delta_{hkl}$ (nm <sup>-1</sup> )	$d$ values $\delta_{hkl}$ (nm)	Reciprocal of $d$ values $\delta_{hkl}$ (nm <sup>-1</sup> )	$d$ values $\delta_{hkl}$ (nm)	
3.5200	3.5107	3.5107	2.801	3.5714	2.790	3.5842	101
2.3780	2.3812	2.3812	4.211	2.3752	4.271	2.3419	004
1.8920	1.8911	1.8911	5.402	1.8518	5.462	1.8313	200
1.6665	1.6411	1.6411	6.121	1.6339	6.170	1.6207	211
1.4808	1.4712	1.4712	6.970	1.4317	7.100	1.4084	204



**Figure 4.** Absorption spectra of samples S1, S2 and S3.

were found to be highly selective to LPG and H<sub>2</sub> at 350 and 250 °C, respectively against other gases. The most important reason of this outstanding performance is the nanocrystalline nature of TiO<sub>2</sub> film.

#### 5.5 Reproducible sensing cycles of TiO<sub>2</sub> thin films (S1, S2 and S3)

Reproducible behaviour of each sample was tested by conducting 10 similar cycles of gas sensing process. The sensitivity values of each sample was observed to be approximately similar as shown in figures 8(a) and (b).

## 6. Discussion

TiO<sub>2</sub> based thin film (S1, S2 and S3) samples were exposed with six types of gases: LPG, H<sub>2</sub>, CO<sub>2</sub>, NH<sub>3</sub>·Cl<sub>2</sub> and ethanol.

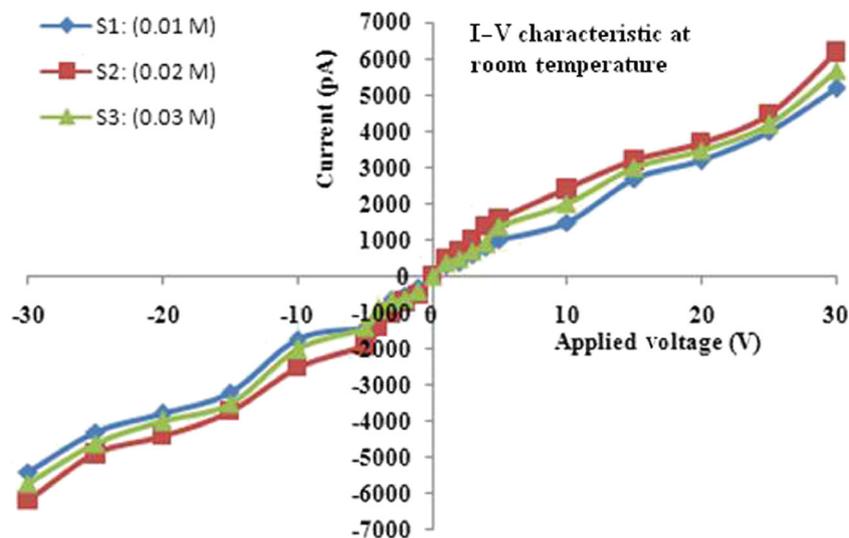


Figure 5.  $I$ - $V$  characteristics of  $\text{TiO}_2$  thin films.

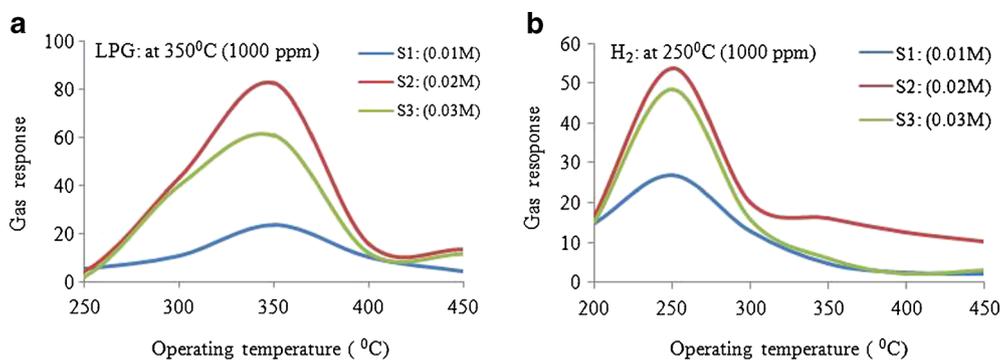


Figure 6. Variation of gas response with operating temperature for (a) LPG and (b)  $\text{H}_2$ .

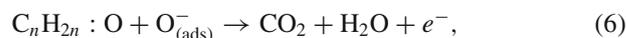
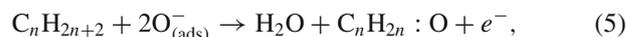
It was responding more or less to all the gases. The samples showed temperature dependent sensing, i.e., the same sample responded to two gases at two different operating temperatures. The same sample may be used to detect two gases just by tuning the respective operating temperature corresponding to the gas. LPG sensitivity values of S2 and S3 at 350 °C were 82 and 61, respectively which were observed to be larger than their sensitivity values (54 and 48, respectively) to  $\text{H}_2$  at 250 °C. Selectivity values of LPG and  $\text{H}_2$  are relatively larger against  $\text{CO}_2$ ,  $\text{NH}_3$ ,  $\text{Cl}_2$  and ethanol.

### 6.1 LPG sensing

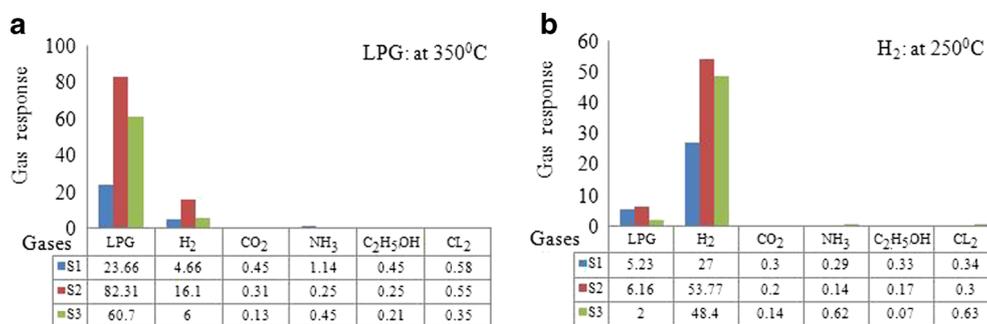
Response of sensors depends on two factors, viz. the speed of chemical reaction on the surface of the grains and speed of diffusion of gas molecules to that surface. At low temperatures, the sensor response is restricted by the speed of chemical reactions. At higher temperature, the sensor response is restricted by the speed of the diffusion of gas molecules to that surface. At some intermediate temperature, the speed values of two processes become equal and at that

point the sensor response reaches its maximum. According to this mechanism, for every gas there is a specific temperature at which the sensor response attains its peak value.

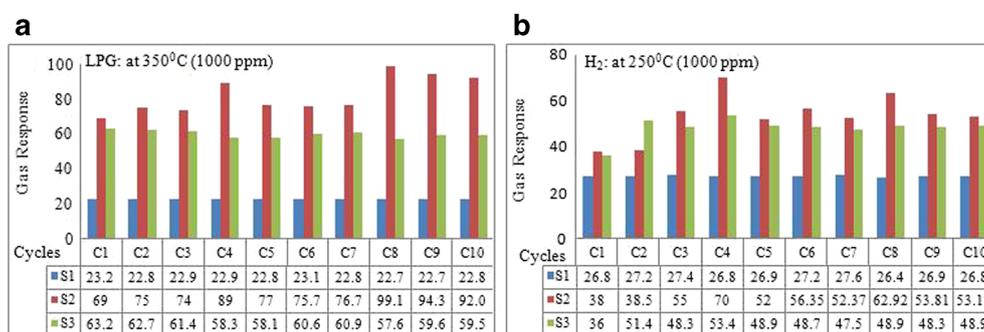
When  $\text{TiO}_2$  thin film is exposed to LPG, the hydrocarbons viz. propane ( $\text{C}_3\text{H}_8$ ) and butane ( $\text{C}_4\text{H}_{10}$ ) present in LPG interact with the adsorbed oxygen ions present on the surface of the sensor. The hydrocarbons are converted to  $\text{CO}_2$  and  $\text{H}_2\text{O}$  due to their interaction with the adsorbed oxygen ions. The overall reaction of LPG molecules with adsorbed oxygen species can be explained based on the following reactions (Sahay and Nath 2008):



where  $\text{C}_n\text{H}_{2n+2}$  denote  $\text{C}_3\text{H}_8$ ,  $\text{C}_4\text{H}_{10}$ , etc and  $\text{C}_n\text{H}_{2n} : \text{O}$  represents partially oxidized intermediates on  $\text{TiO}_2$  surface. This



**Figure 7.** Selectivity of sample S2: (a) LPG at 350 °C and (b) H<sub>2</sub> at 250 °C against various gases.

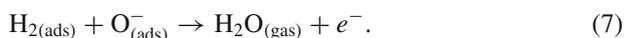


**Figure 8.** Repetition of gas response for samples S1, S2 and S3: (a) LPG at 350 °C and (b) H<sub>2</sub> at 250 °C.

reaction produces CO<sub>2</sub> and H<sub>2</sub>O and releases the trapped electrons back to the conduction band of TiO<sub>2</sub>. As a result the resistance of TiO<sub>2</sub> thin films decreases and conductivity increases upon exposure to LPG.

## 6.2 H<sub>2</sub> sensing

It is well known that oxygen molecules are adsorbed on the surface of TiO<sub>2</sub> to form O<sub>2</sub>, O and O<sup>2-</sup> ions by abstracting electrons from the conduction band of TiO<sub>2</sub> depending on temperature. The oxygen species are O<sub>2</sub> molecules below 100 °C, O<sub>2</sub><sup>-</sup> between 100 and 300 °C, and O<sup>2-</sup> above 300 °C (Choi *et al* 2009).



When TiO<sub>2</sub> thin films are exposed to H<sub>2</sub> gas, H<sub>2</sub> gas reacts with the adsorbed O<sup>-</sup> ions on the surface of TiO<sub>2</sub> thin films according to (7). Then electrons are returned back to the films. Increase of electrons decreases the resistance of TiO<sub>2</sub> thin films and conductivity increases upon exposure to H<sub>2</sub>.

## 7. Conclusions

Simple spray pyrolysis technique was observed to be useful for the preparation of nanostructure films of TiO<sub>2</sub>. The size of TiO<sub>2</sub> nanoparticles varies with variation in the concentration of precursor solution. The grain sizes (S1, S2 and S3) calculated from XRD match well with the grain sizes (S1, S2 and

S3) observed from TEM. The *d* values (S1 and S2) calculated from XRD and *d* values (S1 and S2) calculated from electron diffraction patterns (TEM) are similar. Nanocrystalline TiO<sub>2</sub> thin films were observed to be sensitive to LPG at 350 °C and to hydrogen at 250 °C. The films may be useful for the fabrication of temperature dependent sensor. Nanocrystalline nature was observed to be useful in gas sensing. TiO<sub>2</sub> films showed repeatable gas sensing performance.

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